

Notice of References Cited

Application/Control No.

10/536,669

Applicant(s)/Patent Under
Reexamination
NAKAYOSHI ET AL.

Examiner

ROBERT LOEWE

Art Unit

1796

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,384,075 A	01-1995	Okami, Takehide	252/511
*	B	US-5,447,661 A	09-1995	Takahashi et al.	252/511
*	C	US-5,770,298 A	06-1998	Nakamura et al.	428/195.1
*	D	US-5,908,897 A	06-1999	Nakamura et al.	524/862
*	E	US-6,010,646 A	01-2000	Schleifstein, Robert A.	252/500
*	F	US-6,090,887 A	07-2000	Nakamura et al.	524/862
*	G	US-6,136,447 A	10-2000	Nakamura et al.	399/338
*	H	US-6,140,446 A	10-2000	Fujiki et al.	528/15
*	I	US-6,225,433 B1	05-2001	Isshiki et al.	528/15
*	J	US-6,469,090 B2	10-2002	Azechi et al.	524/492
*	K	US-6,734,250 B2	05-2004	Azechi et al.	524/588
*	L	US-6,797,772 B2	09-2004	Nakayoshi et al.	524/731
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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